MT3208A/B

N-Channel Power MOSFET

80V, 110A, $6.5 \text{m}\,\Omega$

Features

- $R_{DS(on)} = 6.5 \text{m} \Omega / V_{GS} = 10 \text{V}, I_D = 30 \text{A}$
- · Fast Switching Speed
- · Low Gate Charge
- High Performance Trench Technology for Extr emely Low $R_{DS(on)}$
- · High Power and Current Handling Capability
- RoHS Compliant

General Description

This N-Channel MOSFET is produced using MOS-TECH Semiconductor's advanced PowerTrench process that has been especially tailored to minimize the on-state resistance and yet maintain superior switching performance.

Applications

- · DC-DC primary bridge
- DC-DC Synchronous rectification

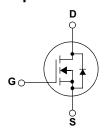
MT3208A

Hot swap



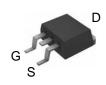
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Simplified Schematic



MARKING DIAGRAM & PIN ASSIGNMENT





TO-263-2L

Package Code

MT3208A: T0-220FB-3L MT3208B: T0-263-2L

Date Code

Lot No

MOSFET Maximum Ratings T_C = 25°C unless otherwise noted

Symbol	Parameter				Ratings	Units
V _{DSS}	Drain to Source Voltage				80	V
V_{GSS}	Gate to Source Voltage	ge			±25	V
	Drain Curren - Continuous (Silicon Limited) T _C = 25°C			110		
	- Continuous(Package Limited)		T _C =100°C	70	A	
ID	- Continuous		T _C =125 °C(Note 1a)	50		
	- Pulsed			400	А	
E _{AS}	Single Pulsed Avalan	che Energy		(Note 3)	530	mJ
P _D	Danie dia dia	-	- T _C = 25°C	(Note 1a)	200	W
	Power Dissipation - T _A = 25°C		- T _A = 25°C	(Note 1b)	2.2	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range			-55 to +150	°C	

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Thermal Characteristics

Symbol	Parameter		Ratings	Units
$R_{\theta JC}$	Thermal Resistance, Junction to Case	(Note 1)	0.75	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	62.5	- °C/VV

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
MT3208A/B	MT3208A/B	TO-220/TO-263	-	-	50

Electrical Characteristics $T_C = 25^{\circ}C$ unless otherwise noted

Parameter	Test Co	onditions	Min	Тур	Max	Units
acteristics						
Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_C$	3S = 0V	80	-	-	V
Zero Gate Voltage Drain Current	V _{DS} = 24V		-	-	1	
	$V_{GS} = 0V$	$T_{\rm C} = 150^{\rm o}{\rm C}$	-	-	250	μΑ
Gate to Source Leakage Current	V _{GS} = ±20V		-	-	±100	nA
	acteristics Drain to Source Breakdown Voltage Zero Gate Voltage Drain Current	acteristics Drain to Source Breakdown Voltage $I_D = 250\mu A$, V_C Zero Gate Voltage Drain Current $V_{DS} = 24V$ $V_{CS} = 0V$				

On Characteristics

V _{GS(TH)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}$, $I_D = 250\mu A$	-	3.0	-	V
		I _D = 30A, V _{GS} = 10V	-	6.5	-	
rna (an)	Drain to Source On Resistance	$I_D = 30A$, $V_{GS} = 4.5V$	-	-	-	mΩ
^r DS(ON)	Drain to Source On Resistance	I _D = 30A, V _{GS} = 10V, T _J = 175°C	-	-	-	

Dynamic Characteristics

C _{ISS}	Input Capacitance	V - 15V V - 0V	-	3150	-	pF
C _{OSS}	Output Capacitance	V _{DS} = 15V, V _{GS} = 0V, f = 1MHz	-	890	-	pF
C _{RSS}	Reverse Transfer Capacitance	1 111112	-	441	-	pF
R _G	Gate Resistance	$V_{GS} = 0V$, $V_{DS}=0V$, $f = 1MHz$	-	1	-	Ω
Q _{g(TOT)}	Total Gate Charge at 10V	V _{GS} = 0V to 10V	-	158	-	nC
$Q_{g(5)}$	Total Gate Charge at 5V	V _{GS} = 0V to 5V	-	80	-	nC
$Q_{g(TH)}$	Threshold Gate Charge	$V_{GS} = 0V \text{ to } 1V$ $V_{DD} = 15V$ $I_{D} = 20A$	-	3.0	4.0	nC
Q_{gs}	Gate to Source Gate Charge	$I_{D} = 20A$ $I_{d} = 1.0 \text{mA}$	-	17	-	nC
Q _{gs2}	Gate Charge Threshold to Plateau	·g	-	6.0	-	nC
Q_{gd}	Gate to Drain "Miller" Charge		-	31	-	nC

Switching Characteristics $(V_{GS} = 10V)$

t _{ON}	Turn-On Time		-	45	-	ns
t _{d(ON)}	Turn-On Delay Time		-	20	-	ns
t _r	Rise Time	V _{DD} = 15V, I _D = 30A,	-	20	-	ns
t _{d(OFF)}	Turn-Off Delay Time	$V_{GS} = 4.5V, R_{GS} = 4.7\Omega$	-	80	-	ns
t _f	Fall Time		-	45	-	ns
toff	Turn-Off Time		-	62	-	ns

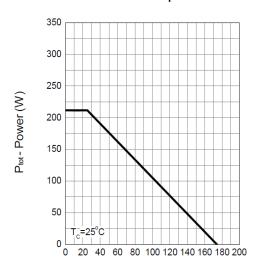
Drain-Source Diode Characteristics

V _{SD}	Source to Drain Diode Voltage	I _{SD} = 30A,	-	-	1.25	V
	Source to Drain blode voltage	$I_{SD} = 30A$,	-	-	1.0	V
t _{rr}	Reverse Recovery Time	$I_{SD} = 30A$, $dI_{SD}/dt = 100A/\mu s$	-	-	32	ns
Q _{RR}	Reverse Recovered Charge	$I_{SD} = 30A, dI_{SD}/dt = 100A/\mu s$	-	-	18	nC

Notes. 1: Package current limitation is 80A. 2: Starting $T_J = 25^{\circ}C$, L = 0.5MH $I_{AS} = 64A$, $V_{DD} = 37V$, $V_{GS} = 10V$. 3: Pulse width = 100s.

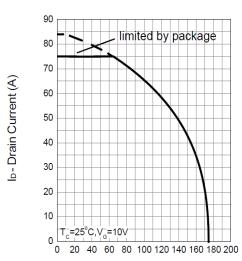
Typical Operating Characteristics





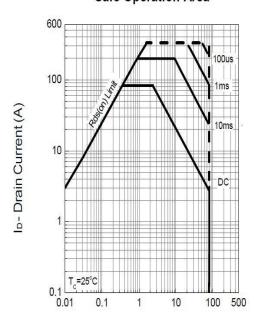
T_j- Junction Temperature (°C)

Drain Current



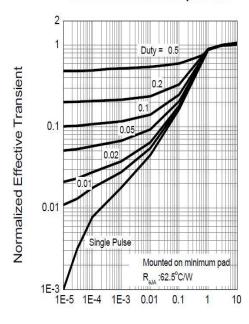
T_j - Junction Temperature (°C)

Safe Operation Area



V_{DS} - Drain - Source Voltage (V)

Thermal Transient Impedance

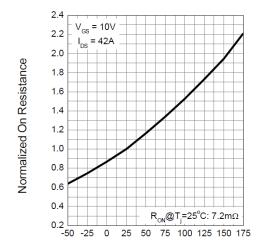


Square Wave Pulse Duration (sec)

Typical Operating Characteristics (Cont.) Output Characteristics Drain-Source On Resistance 10 160 = 6,7,8,9,10V 140 $R_{DS(ON)}$ - On - Resistance ($m\Omega$) 5.5V 9.0 120 Ip-Drain Current (A) 100 8.0 80 V_{GS} =10∨ 60 5V 40 7.0 20 4.5V 6.0 20 60 100 ID-Drain Current (A) V_{DS} - Drain-Source Voltage (V) **Drain-Source On Resistance Gate Threshold Voltage** 17 1.6 I_{DS}=42A 1.4 Normalized Threshold Vlotage RDS(ON) - On - Resistance (m\Omega) 15 1.2 13 11 8.0 0.6 7 0.4 5 10 25 50 75 100 125 150 175 V_{GS} - Gate - Source Voltage (V) T_j - Junction Temperature (°C)

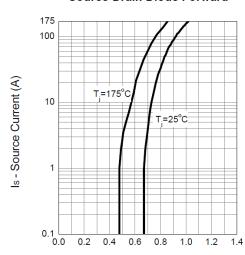
Typical Operating Characteristics (Cont.)

Drain-Source On Resistance



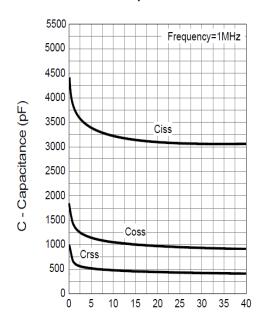
T_j- Junction Temperature (°C)

Source-Drain Diode Forward



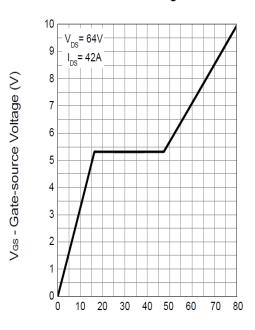
V_{SD} - Source-Drain Voltage (V)

Capacitance



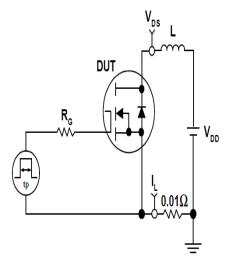
V_{DS} - Drain - Source Voltage (V)

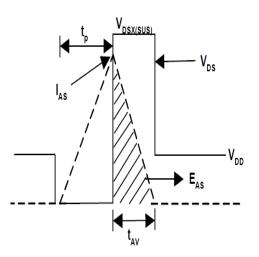
Gate Charge



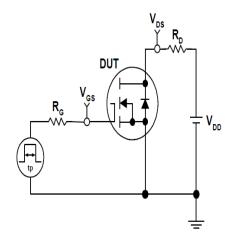
Q_G - Gate Charge (nC)

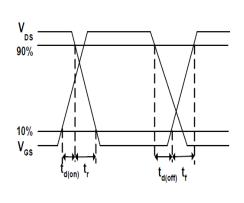
Avalanche Test Circuit and Waveforms





Avalanche Test Circuit and Waveforms





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